ChemComm



COMMUNICATION

View Article Online



Cite this: Chem. Commun., 2015 51 10494

Received 20th April 2015, Accepted 11th May 2015

DOI: 10.1039/c5cc03220b

www.rsc.org/chemcomm

Ternary chalcogenide micro-pseudocapacitors for on-chip energy storage†

Narendra Kurra. Chuan Xia. M. N. Hedhili and H. N. Alshareef*

We report the successful fabrication of a micro-pseudocapacitor based on ternary nickel cobalt sulfide for the first time, with performance substantially exceeding that of previously reported micro-pseudocapacitors based on binary sulfides. The CoNi₂S₄ micro-pseudocapacitor exhibits a maximum energy density of 18.7 mW h cm⁻³ at a power density of 1163 mW cm⁻³, and opens up an avenue for exploring a new family of ternary oxide/sulfide based micro-pseudocapacitors.

Microsupercapacitors (MSCs) are promising devices for next generation on-chip energy storage due to their high power density, which can complement high energy density batteries. 1-3 Additional attributes of MSCs include excellent rate capability, a long cycling lifetime, and superior volumetric capacity to their conventional sandwich counterparts.^{3,4} The planar configuration of MSCs can allow robust integration with functional electronic devices such as microsensors and biomedical implants as micro-power units.⁵⁻⁷ Hence, a great deal of research has been focused on a variety of nanostructured electroactive materials that are amenable to fabricate in-plane MSCs.3,4

Various MSCs based on conducting porous carbon were fabricated employing conventional photolithography and deposition or etching schemes. For example, high surface area carbon forms such as activated, 8 carbide derived, 2 onion like 9 and carbon nanotubes¹⁰ have been patterned employing photolithography followed by deposition methods such as ink-jet printing, electrophoretic and spray deposition. Further, high temperature chemical vapor deposition (CVD) was also employed in growing carbon nanotubes (CNTs) and graphene or both, selectively over the patterned current collectors. 11,12 Of late, due to compatible solution processability, graphene oxide (GO) has become attractive candidate material for making MSCs employing an etching scheme in a photolithography technique¹³ or innovative direct

Materials Science and Engineering, King Abdullah University of Science and Technology (KAUST), Thuwal 23955-6900, Saudi Arabia.

E-mail: husam.alshareef@kaust.edu.sa

laser scribing methods. 14,15 Further, in order to improve the limited capacitance of carbon based MSCs, several pseudocapacitive materials including metal oxides/hydroxides (RuO2, MnO2 and Ni(OH)2)16-18 and even conducting polymers (PPY, PANI, PEDOT)19-22 were employed to fabricate high capacity micro-pseudocapacitors. These pseudocapacitive materials can undergo fast redox reactions at their nanostructured surfaces, contributing to the higher values of capacity and hence energy density. 16-22

Recently, new electrode materials in the form of binary and ternary sulfides have been explored as potential candidates for pseudocapacitors. 23-25 However, most of the studies have been focused on their synthesis and investigation of their electrochemical performance in 3-electrode configuration. To exploit the practical usage of these new materials, it is highly desirable to build energy storage devices in a 2-electrode configuration. 25,26 In-plane MSCs based on binary metal sulfides such as MoS2 and VS₂ have been fabricated, which showed an areal cell capacitance of 5-8 mF cm⁻².^{27,28} Moreover, nanostructured sulfides, in particular, ternary nickel cobalt sulfides, have become outstanding electrode materials due to their higher conductivity and richer redox reactions than the single component sulfides due to contributions from nickel and cobalt ions. 23-25 In addition, it was demonstrated that these ternary cobalt nickel sulfides exhibit higher electronic conductivity and richer redox reactions than their ternary oxide counter-parts, resulting in higher capacity values.²⁹ Here, we demonstrate the fabrication of ternary sulfide micro-pseudocapacitors with excellent volumetric capacitance and energy density.

We report the fabrication of a nanostructured ternary cobalt nickel sulfide micro-pseudocapacitor employing electrochemical co-deposition over the rGO/Au/patterned photoresist. The rGO free-standing films are prepared through vacuum filtration from its dispersion. Before doing lift-off, ternary cobalt nickel sulfide was electrodeposited to ensure uniform deposition over the entire area. The resulting CoNi2S4 MSC exhibits a volumetric capacitance of 211 F cm⁻³ (an areal capacitance of 11.6 mF cm⁻²), corresponding to an energy density of 18.7 mW h cm⁻³ at a power density of 1163 mW cm⁻³. This is the best reported performance of any sulfide based micro-pseudocapacitor.

[†] Electronic supplementary information (ESI) available. See DOI: 10.1039/c5cc03220b

[‡] Contributed equally to the work.

Communication ChemComm

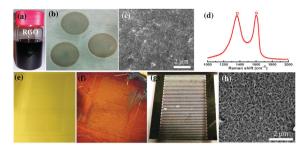


Fig. 1 Digital photographs showing (a) rGO dispersion, (b) freely floating rGO thin films obtained through vacuum filtration, (c) SEM micrograph showing the morphology of rGO film, (d) Raman spectrum of rGO. Photographs showing (e) Au coated patterned photoresist, (f) transferring of rGO onto Au/patterned photoresist, (g) electrochemical co-deposition of CoNi₂S₄ followed by liftoff in resulting CoNi₂S₄ interdigitated electrodes, (h) nanostructured morphology of CoNi₂S₄.

Fig. 1a shows the rGO dispersion (described in the ESI†) that was used to obtain rGO thin films by vacuum filtration over the anodic alumina membrane. 30-32 The alumina membrane was subsequently dissolved in 3 M NaOH to result in the freely floating film of rGO over the water bath as shown in Fig. 1b. This rGO film is comprised of tightly packed small flakes (lateral dimensions, 200 nm) giving rise to innumerable edges, domain boundaries, and interfaces. Raman spectrum of rGO film shows broad D and G bands centered at 1367 (FWHM, 206 cm⁻¹) and 1598 cm⁻¹ (FWHM, 91 cm⁻¹), respectively. The D band originates from the presence of defects and functional groups while the G band corresponds to symmetric stretching of the sp² carbon lattice with E_{2g} symmetry. 33 The $I_{\rm D}/I_{\rm G}$ ratio of rGO films was found to be in the range of 0.8-0.9 and the sp2 crystallite size was estimated using the below formula, 34 and was found to be 10–15 nm. E_{laser} is the laser excitation energy (eV) in the following equation:

$$L_{\rm a} (\rm nm) = 560/E_{\rm laser}^{4} (I_{\rm D}/I_{\rm G})^{-1}$$
 (1)

We have followed the conventional photolithography liftoff protocol to fabricate ternary nickel cobalt sulfide micropseudocapacitors (the detailed fabrication process is illustrated in the ESI,† Fig. S1). Initially, a metal coated patterned photoresist chip was employed as a platform to transfer the free-standing rGO film as shown in Fig. 1e and f. Reduced graphene oxide (rGO) provides a functional conducting graphitic platform which, when used as current collector, improves the nucleation and growth of pseudocapacitive materials compared to metal current collectors.³⁵ Recently, Du et al. have demonstrated a physical approach for synthesizing a nanocomposite of CoNi₂S₄-graphene with excellent electrochemical performance.³⁶ We have found that compared to metal surfaces such as Au or Ni, the functional rGO surface helps in the uniform growth of ternary sulfides (Fig. S2, ESI†). It was observed that the growth of CoNi₂S₄ was non-uniform over the Au current collectors as is evident from the SEM micrographs shown in Fig. S2 (ESI†). However, Au acts as a conductive support/ current collector while the rGO layer helps in the homogenous and uniform nucleation and growth of CoNi₂S₄ during the electrochemical co-deposition process. Electrochemical co-deposition was carried out before photoresist lift-off to ensure uniform

electric field and uniform growth of CoNi2S4 over the entire chip. Doing the photoresist lift-off before electrodeposition would have created irregular electric fields and non-uniform growth of the CoNi₂S₄. The strong adherence of nickel cobalt sulfide onto the rGO film is evident since the final step of liftoff involved rigorous ultrasonication to make the CoNi₂S₄/rGO finger electrodes. It is obvious from the SEM micrograph shown in Fig. 1h that the electrodeposited CoNi₂S₄ layer has a uniform monolithic morphology. We have considered rGO thin film as a platform for growing CoNi₂S₄ heterostructures with interdigitated electrode patterns in evaluating its electrochemical performance in a 2-electrode configuration.

XPS analysis was carried out in order to determine the chemical composition of the sample and the oxidation state of detected elements. High resolution XPS spectra of Co 2p, Ni 2p, and S 2p core levels have been recorded and are shown in Fig. 2. The high resolution XPS spectra match well with those obtained for ternary nickel cobalt sulfides CoNi₂S₄³⁷ and NiCo₂S₄.^{38,39} Precise distinction between the two sulfides is difficult due to the similarities of the shape and binding energies of the Co 2p, Ni 2p and S 2p core levels. The elemental composition was obtained using XPS by applying the appropriate relative sensitivity factors (RSFs) to the integrated peak areas of specific core levels for the different elements. The atomic ratio S/Ni/Co was estimated to be 4:2:1, which can be assigned to CoNi₂S₄. The Ni 2p_{3/2} portion of the Ni 2p spectrum was fitted using three components.

The Ni 2p_{3/2} components observed at 852.9 and 855.7 eV correspond to Ni²⁺ and Ni³⁺ species, respectively.^{37,40} The third Ni 2p_{3/2} component located at 861.3 eV is related to a shake-up satellite of Ni³⁺ species.^{37,40} The Co 2p_{3/2} part of the Co 2p spectrum was fitted using three components as well. The Co $2p_{3/2}$ component observed at 778.2 is attributed to Co^{3+} species, while the components located at 781.0, and 786. 3 eV correspond to the Co²⁺ main peak accompanied with its shake-up satellite, respectively.^{37,40} For the S 2p high resolution XPS spectrum, the peak observed at 161.3 eV corresponds to the S $2p_{3/2}$ core level, which is typical of metal sulfur bounds in the ternary metal sulfides⁴¹ and consistent with nickel and

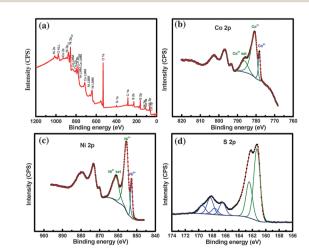


Fig. 2 X-ray photoelectron spectroscopy (XPS) of CoNi₂S₄ (a) survey scan and core-level spectra of (b) Co 2p, (c) Ni 2p and (d) S 2p

ChemComm Communication

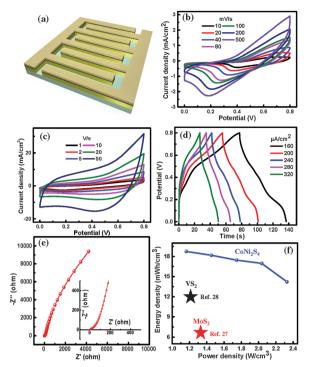


Fig. 3 (a) Schematic showing the interdigitated electrodes of CoNi₂S₄. (b) and (c) CVs of CoNi₂S₄ MSC in 1 M KOH in a 2-electrode configuration. (d) Charge-discharge curves at different current densities. (e) Impedance spectra of the device, the inset shows the high frequency region of the spectrum. (f) Ragone plot comparing the energy and power densities of the CoNi₂S₄ micro-pseudocapacitor with respect to MoS₂ and VS₂ micropseudocapacitors reported in the literature.

cobalt sulfides.41 The S 2p3/2 peaks observed at 166.5 eV and 168.3 eV are attributed to surface sulfur with high oxide states, to sulfites and sulfates, respectively.

The electrochemical performance of the CoNi₂S₄ micropseudocapacitor was tested in a 2-electrode configuration in 1 M KOH electrolyte. Unlike the EDLC behavior of an rGO MSC where the charge is stored through the electrostatic accumulation of electrolytic ions, redox behavior is observed from the CoNi₂S₄ MSC (see Fig. S3, ESI[†]). As shown in Fig. 3a, the redox peaks appear at different scan rates due to the redox behavior of Co⁺⁴/Co⁺³/Co⁺² and Ni⁺³/Ni⁺² couples, mediated by the hydroxyl ions (OH⁻) in the electrolyte. Since sulfur belongs to the same group of oxygen, OH⁻ ions can induce electrochemical oxidation and reduction of CoNi₂S₄ in alkaline medium similar to that of metal oxides/hydroxides. However, it is difficult to deconvolute the contributions of Ni and Co due to the broad nature of redox peaks, most probably due to reversible formation of redox couples such as NiS/NiS(OH) and CoS/CoS(OH)/CoSO. At a scan rate of 10 mV s⁻¹, CoNi₂S₄ shows an areal cell capacitance of 11.6 mF cm⁻², which is superior to binary metal oxide (areal cell capacitance of 1-5 mF cm⁻²) and sulfide (VS₂, MoS₂; C_A = 4-8 mF cm⁻²) based micro-pseudocapacitors. It was found that the areal capacitance was gradually increasing from 1.7 to 11.6 mF cm⁻² (at a current density of 160 μA cm⁻²) due to more loading of CoNi₂S₄ when the deposition cycles were increased from 1 to 6 (see Fig. S4, ESI†). Due to the planar configuration of

the CoNi₂S₄ interdigitated electrodes, CVs were recorded even at higher scan rates of 1-50 V s⁻¹ as shown in Fig. 3c. Similarly, charge-discharge curves of the CoNi₂S₄ MSC at different current densities were recoded as shown in Fig. 3d. CD profiles are highly non-linear, clearly demonstrating the pseudocapacitive behavior of the CoNi2S4 electrodes. We have found that this micro-pseudocapacitor exhibits an areal cell capacitance of 11.6 mF cm⁻² (thickness of CoNi₂S₄/rGO is about 0.55 μm), which corresponds to a volumetric capacitance of 211 F cm⁻³. while the pristine rGO based MSC shows a much lower areal capacitance of 0.3 mF cm⁻² with a volumetric capacitance of 40 F cm⁻³. Cycling stability of the CoNi₂S₄ MSC was tested by continuous charging-discharging at a current density of 320 μA cm⁻², which showed a capacitance retention of 80% after 5000 cycles with a coulombic efficiency of above 95% (see Fig. S5, ESI†). Further, a solid state CoNi₂S₄ MSC was fabricated by employing PVA/KOH gel electrolyte, which exhibits an areal capacitance of 2.8 mF cm⁻² (see Fig. S6, ESI†). Thus, enhanced values of areal and volumetric capacitance of the CoNi₂S₄ MSC are due to the pseudocapacitive nature unlike the EDLC behavior of carbon based MSCs. This volumetric capacitance is still higher than MoS₂ MSC (178 F cm⁻³). Thus, these ternary CoNi₂S₄ with impressive redox contributions from the Ni and Co metals as well as facile ionic diffusion through the nanostructured electrodes give rise to higher volumetric capacitance. The impedance spectrum for the CoNi₂S₄ micro-pseudocapacitor is shown in Fig. 3e. The presence of a semi-circle in the high frequency region is due to charge-transfer resistance across the electrode/electrolyte interface with an equivalent series resistance (ESR) of 5 Ω (see the inset of Fig. 3e). An optimized CoNi₂S₄ micro-pseudocapacitor exhibits a maximum energy density of 18.7 mW h cm⁻³ at a power density of 1163 mW cm⁻³. The energy density values are at least twice that of carbon⁸⁻¹⁵ and metal oxide based MSCs^{16,17} $(E = 1-10 \text{ mW h cm}^{-3})$ fabricated in the literature. As shown in the Ragone plot in Fig. 3f, the CoNi₂S₄ MSC exhibits superior energy density over the binary sulfide based MSCs such as MoS2 $(E = 6 \text{ mW h cm}^{-3})^{27} \text{ and VS}_2 (E = 15 \text{ mW h cm}^{-3}) \text{ (see Table S1,}$ ESI†).²⁸ The CoNi₂S₄ MSC exhibits a maximum power density of 2327 mW cm⁻³ even at an energy density of 14.2 mW h cm⁻³. This study opens up the possibility of employing ternary sulfides as potential candidate electrode materials for on-chip energy storage with superior volumetric capacitance and energy density.

In summary, we have demonstrated the successful fabrication of a micro-pseudocapacitor based on ternary nickel cobalt sulfide. This was achieved by employing single-step electrochemical co-deposition of nickel cobalt sulfide over transferred reduced graphene oxide (rGO) thin films followed by photoresist lift-off. The fabricated CoNi₂S₄ micro-pseudocapacitor exhibits a maximum areal cell capacitance of 11.6 mF cm⁻² with a volumetric capacitance of 211 F cm⁻³. The maximum energy density of 18.7 mW h cm⁻³ at a power density of 1163 mW cm⁻³ was achieved, which is superior to the binary sulfide micro-supercapacitors reported in the literature. This study may open up an opportunity to fabricate various kinds of ternary oxide/ sulfide based micro-pseudocapacitors.

Research reported in this publication was supported by King Abdullah University of Science and Technology (KAUST).

Communication

The authors thank the Advanced Nanofabrication, Imaging and Characterization Laboratory at KAUST for their excellent support.

Notes and references

- 1 P. Simon and Y. Gogotsi, Nat. Mater., 2008, 7, 845.
- 2 J. Chmiola, C. Largeot, P. L. Taberna, P. Simon and Y. Gogotsi, Science, 2010, **328**, 480.
- 3 M. Beidaghi and Y. Gogotsi, Energy Environ. Sci., 2014, 7, 867.
- 4 G. Xiong, C. Meng, R. G. Reifenberger, P. P. Irazoqui and T. S. Fisher, Electroanalysis, 2014, 26, 30.
- 5 F. Simjee, P. H. Chou, Everlast: Long-life, Supercapacitor-operated Wireless Sensor Node, Low Power Electronics and Design, 2006. ISLPED'06. Proceedings of the 2006 International Symposium on, 4-6 Oct. 2006, pp. 197-202.
- 6 Z. L. Wang, Adv. Mater., 2012, 24, 280-285.
- 7 Z. L. Wang and W. Wu, Angew. Chem., Int. Ed., 2012, 51, 11700–11721.
- 8 D. Pech, M. Brunet, P. L. Taberna, P. Simon, N. Fabre, F. Mesnilgrente, V. Cońed'era and H. Durou, J. Power Sources, 2010, 195, 1266.
- D. Pech, M. Brunet, H. Durou, P. Huang, V. Mochalin, Y. Gogotsi, P.-L. Taberna and P. Simon, Nat. Nanotechnol., 2010, 5, 651.
- 10 M. Beidaghi and C. L. Wang, Adv. Funct. Mater., 2012, 22, 4501.
- 11 J. Lin, C. Zhang, Z. Yan, Y. Zhu, Z. Peng, R. H. Hauge, D. Natelson and J. M. Tour, Nano Lett., 2012, 13, 72.
- 12 G. Xiong, C. Meng, R. G. Reifenberger, P. P. Irazoqui and T. S. Fisher, Energy Technol., 2014, 2, 897.
- 13 Z. S. Wu, K. Parvez, X. Feng and K. Müllen, Nat. Commun., 2013, 4, 2487,
- 14 W. Gao, N. Singh, L. Song, Z. Liu, A. L. M. Reddy, L. Ci, R. Vajtai, Q. Zhang, B. Wei and P. M. Ajayan, Nat. Nanotechnol., 2011, 6, 6.
- 15 M. F. El-Kady and R. B. Kaner, Nat. Commun., 2013, 4, 1475
- 16 T. M. Dinh, K. Armstrong, D. Guay and D. Pech, J. Mater. Chem. A, 2014, 2, 7170.
- W. Si, C. Yan, Y. Chen, S. Oswald, L. Han and O. G. Schmidt, Energy Environ. Sci., 2013, 6, 3218.
- 18 N. Kurra, N. A. Alhebshi and H. N. Alshareef, Adv. Energy Mater., 2014, 4, 1401303.
- 19 M. Beidaghi and C. L. Wang, Electrochim. Acta, 2011, 56, 9508.

- 20 K. Wang, W. Zou, B. Quan, A. Yu, H. Wu, P. Jiang and Z. Wei, Adv. Energy Mater., 2011, 1, 1068.
- 21 C. Meng, J. Maeng, S. W. M. John and P. P. Irazoqui, Adv. Energy Mater., 2014, 4, 1301269.
- 22 N. Kurra, M. K. Hota and H. N. Alshareef, Nano Energy, 2015, 13, 500.
- 23 H. Wan, J. Jiang, J. Yu, K. Xu, L. Miao, L. Zhang, H. Chen and Y. Ruan, CrystEngComm, 2013, 15, 7649.
- 24 S. Peng, L. Li, C. Li, H. Tan, R. Cai, H. Yu, S. Mhaisalkar, M. Srinivasan, S. Ramakrishna and Q. Yan, Chem. Commun., 2013, 49, 10178.
- 25 W. Chen, C. Xia and H. N. Alshareef, ACS Nano, 2014, 8, 9531.
- 26 M. D. Stoller and R. S. Ruoff, Energy Environ. Sci., 2010, 3, 1294.
- 27 L. Cao, S. Yang, W. Gao, Z. Liu, Y. Gong, L. Ma, G. Shi, S. Lei, Y. Zhang, S. Zhang, R. Vajtai and P. M. Ajayan, Small, 2013, 9, 2905.
- 28 J. Feng, X. Sun, C. Wu, L. Peng, C. Lin, S. Hu, J. Yang and Y. Xie, J. Am. Chem. Soc., 2011, 133, 17832.
- 29 J. Xiao, X. Zeng, W. Chen, F. Xiao and S. Wang, Chem. Commun., 2013, 49, 11734-11736.
- 30 W. S. Hummers and R. E. Offeman, J. Am. Chem. Soc., 1958, 80, 1339.
- 31 D. Li, M. B. Muller, S. Gilje, R. B. Kaner and G. G. Wallace, Nat. Nanotechnol., 2008, 3, 101.
- 32 M. Shahid, N. Yesibolati, F. M. Ross and H. N. Alshareef, J. Power Sources, 2014, 263, 239.
- 33 A. C. Ferrari and J. Robertson, Phys. Rev. B: Condens. Matter Mater. Phys., 2000, 61, 14095.
- 34 M. A. Pimenta, G. Dresselhaus, M. S. Dresselhaus, L. G. Cançado, A. Jorioa and R. Saito, Phys. Chem. Chem. Phys., 2007, 9, 1276.
- 35 Z.-S. Wu, G. Zhou, L.-C. Yin, W. Ren, F. Li and H.-M. Cheng, Nano Energy, 2012, 1, 107.
- 36 W. Du, Z. Wang, Z. Zhu, S. Hu, X. Zhu, Y. Shi, H. Pang and X. Qian, J. Mater. Chem. A, 2014, 2, 9613.
- 37 W. Du, Z. Wang, Z. Zhu, S. Hu, X. Zhu, Y. Shi, H. Pang and X. Qian, J. Mater. Chem. A, 2014, 2, 9613.
- 38 J. Xiao, X. Zheng, W. Chen, F. Xiao and S. Wang, Chem. Commun., 2013, 49, 11734.
- 39 J. Xiao, L. Wan, S. Yang, F. Xiao and S. Wang, Nano Lett., 2014, 14. 831.
- 40 M. Prabu, K. Keptpang and S. Shanmugam, Nanoscale, 2014, 6, 3173.
- 41 Y. Ohno, Phys. Rev. B: Condens. Matter Mater. Phys., 1991, 44, 1281.